



**ALPHA & OMEGA**  
SEMICONDUCTOR

# AOLF66910Q

100V N-Channel AlphaSGT™  
AEC-Q101 Qualified

## General Description

- Trench Power AlphaSGT™ technology
- Low  $R_{DS(ON)}$
- Wave solderable
- Standard Vgsth Driving
- Excellent  $Q_g \times R_{DS(ON)}$  Product (FOM)
- RoHS 2.0 and Halogen-Free Compliant

## Applications

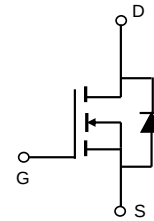
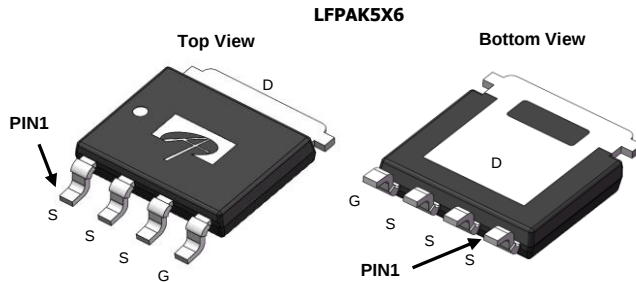
- High Frequency Switching and Synchronous Rectification
- Motor

## Product Summary

|                                 |         |
|---------------------------------|---------|
| $V_{DS}$                        | 100V    |
| $I_D$ (at $V_{GS}=10V$ )        | 187A    |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ ) | < 4.7mΩ |

100% UIS Tested  
100% Rg Tested

Max  $T_J = 175^\circ C$



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOLF66910Q            | LFPAK5X6     | Tape & Reel | 1500                   |

## Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol         | Maximum    | Units      |
|-----------------------------------------|----------------|------------|------------|
| Drain-Source Voltage                    | $V_{DS}$       | 100        | V          |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 20$   | V          |
| Continuous Drain Current                | $I_D$          | 187        | A          |
| $T_C=25^\circ C$                        |                | 132        |            |
| $T_C=100^\circ C$                       |                |            |            |
| Pulsed Drain Current                    | $I_{DM}$       | 748        |            |
| Continuous Drain Current                | $I_{DSM}$      | 26         | A          |
| $T_A=25^\circ C$                        |                | 22         |            |
| $T_A=70^\circ C$                        |                |            |            |
| Avalanche Current <sup>C</sup>          | $I_{AS}$       | 60         | A          |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}$       | 180        | mJ         |
| Power Dissipation <sup>B</sup>          | $P_D$          | 375        | W          |
| $T_C=25^\circ C$                        |                | 187        |            |
| $T_C=100^\circ C$                       |                |            |            |
| Power Dissipation <sup>A</sup>          | $P_{DSM}$      | 7.5        | W          |
| $T_A=25^\circ C$                        |                | 5.2        |            |
| $T_A=70^\circ C$                        |                |            |            |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 175 | $^\circ C$ |

## Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max | Units        |
|--------------------------------------------|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 15  | 20  | $^\circ C/W$ |
| $t \leq 10s$                               |                 |     |     |              |
| Maximum Junction-to-Ambient <sup>A,D</sup> | Steady-State    | 40  | 50  | $^\circ C/W$ |
| Maximum Junction-to-Case                   | Steady-State    | 0.3 | 0.4 | $^\circ C/W$ |

**Electrical Characteristics ( $T_J=25^{\circ}\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                         | Min | Typ        | Max         | Units         |
|-----------------------------|---------------------------------------|------------------------------------------------------------------------------------|-----|------------|-------------|---------------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                    |     |            |             |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}$ , $V_{GS}=0\text{V}$                                          | 100 |            |             | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=100\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^{\circ}\text{C}$              |     |            | 1<br>5      | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 20\text{V}$                                       |     |            | $\pm 100$   | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$                                             | 2.4 | 3          | 3.6         | V             |
| $R_{DS(on)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=20\text{A}$<br>$T_J=175^{\circ}\text{C}$                |     | 3.7<br>8.2 | 4.7<br>10.5 | m $\Omega$    |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=20\text{A}$                                              |     | 82         |             | S             |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$                                               |     | 0.7        | 1           | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current |                                                                                    |     |            | 187         | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                    |     |            |             |               |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=50\text{V}$ , $f=1\text{MHz}$                         |     | 3630       |             | pF            |
| $C_{oss}$                   | Output Capacitance                    |                                                                                    |     | 1080       |             | pF            |
| $C_{rss}$                   | Reverse Transfer Capacitance          |                                                                                    |     | 20         |             | pF            |
| $R_g$                       | Gate resistance                       | $f=1\text{MHz}$                                                                    | 0.6 | 1.4        | 2.1         | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                    |     |            |             |               |
| $Q_{g(10V)}$                | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=50\text{V}$ , $I_D=20\text{A}$                       |     | 47         | 66          | nC            |
| $Q_{gs}$                    | Gate Source Charge                    |                                                                                    |     | 14         |             | nC            |
| $Q_{gd}$                    | Gate Drain Charge                     |                                                                                    |     | 8          |             | nC            |
| $Q_{oss}$                   | Output Charge                         | $V_{GS}=0\text{V}$ , $V_{DS}=50\text{V}$                                           |     | 90         |             | nC            |
| $t_{D(on)}$                 | Turn-On DelayTime                     | $V_{GS}=10\text{V}$ , $V_{DS}=50\text{V}$ , $R_L=2.5\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 13         |             | ns            |
| $t_r$                       | Turn-On Rise Time                     |                                                                                    |     | 6          |             | ns            |
| $t_{D(off)}$                | Turn-Off DelayTime                    |                                                                                    |     | 36         |             | ns            |
| $t_f$                       | Turn-Off Fall Time                    |                                                                                    |     | 9          |             | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=20\text{A}$ , $di/dt=100\text{A}/\mu\text{s}$                                 |     | 39         |             | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}$ , $di/dt=100\text{A}/\mu\text{s}$                                 |     | 41         |             | nC            |

A. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA} \leq 10\text{s}$  and the maximum allowed junction temperature of  $175^{\circ}\text{C}$ . The value in any given application depends on the user's specific board design, and the maximum temperature of  $175^{\circ}\text{C}$  may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}=175^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}=175^{\circ}\text{C}$ .

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}=175^{\circ}\text{C}$ . The SOA curve provides a single pulse rating.

G. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ .

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

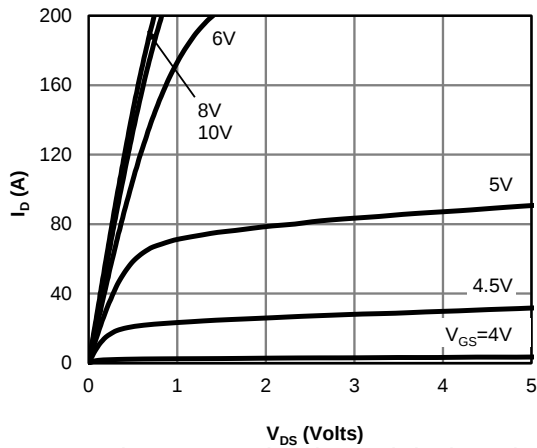


Figure 1: On-Region Characteristics (Note E)

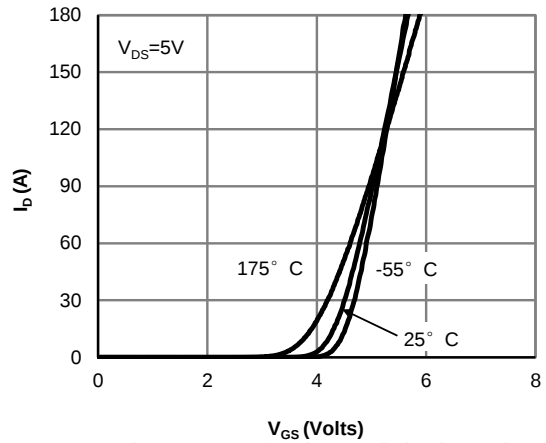


Figure 2: Transfer Characteristics (Note E)

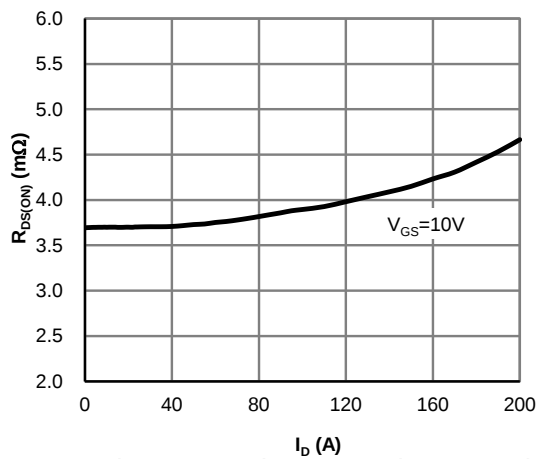


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

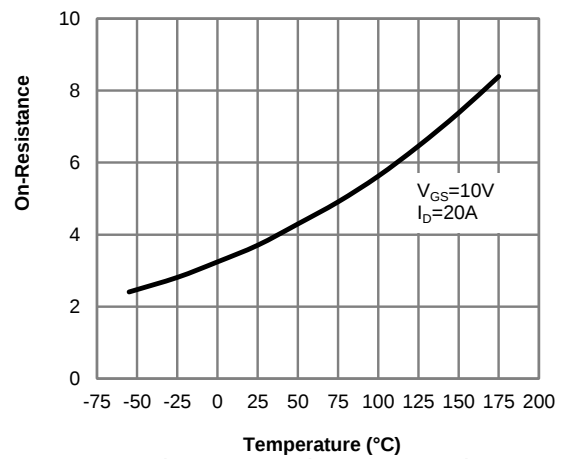


Figure 4: On-Resistance vs. Junction Temperature (Note E)

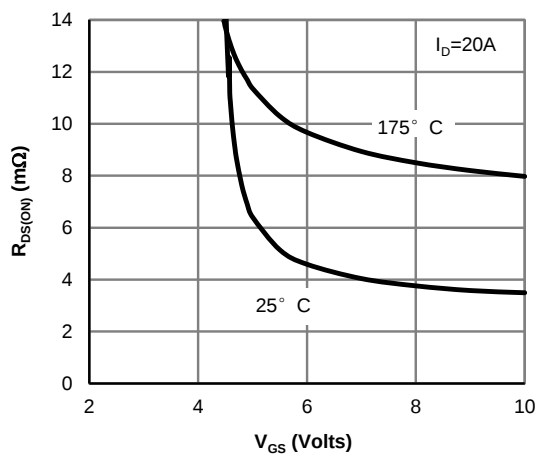


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

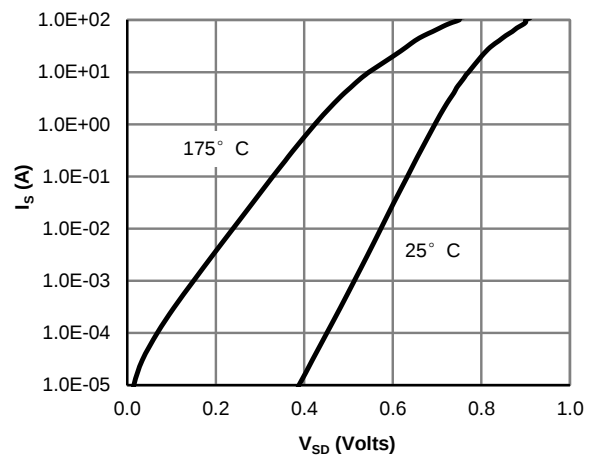
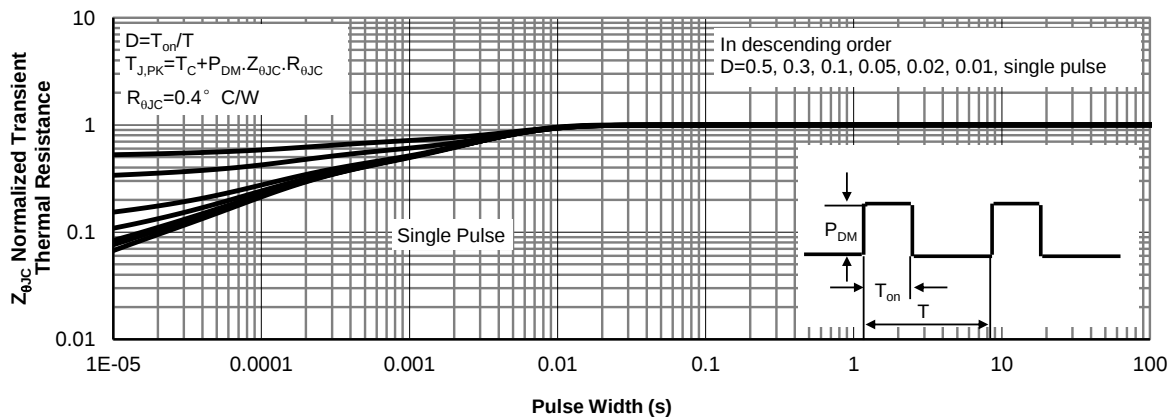
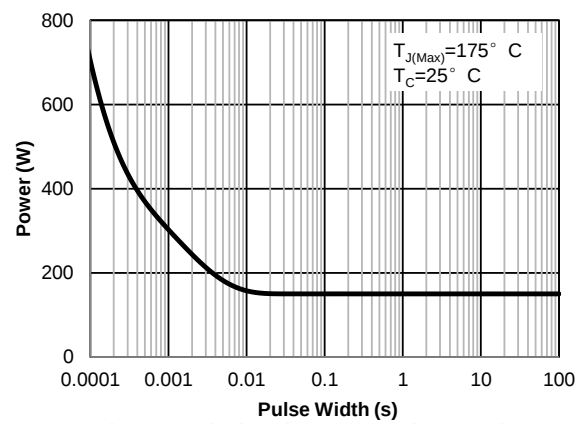
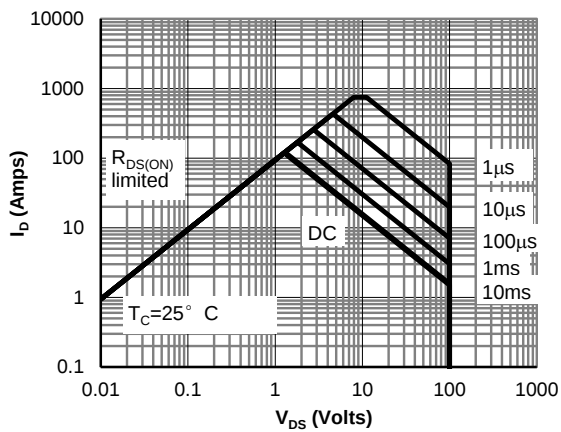
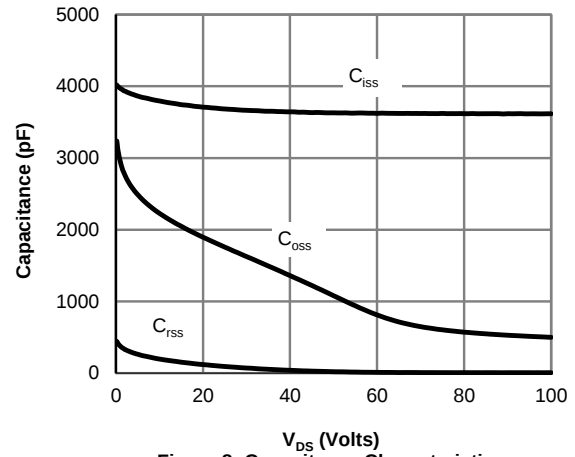
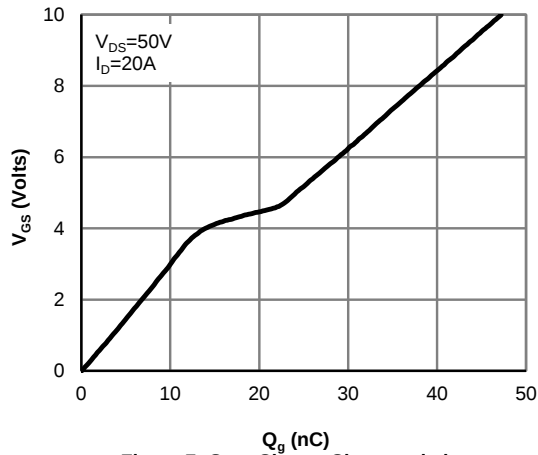
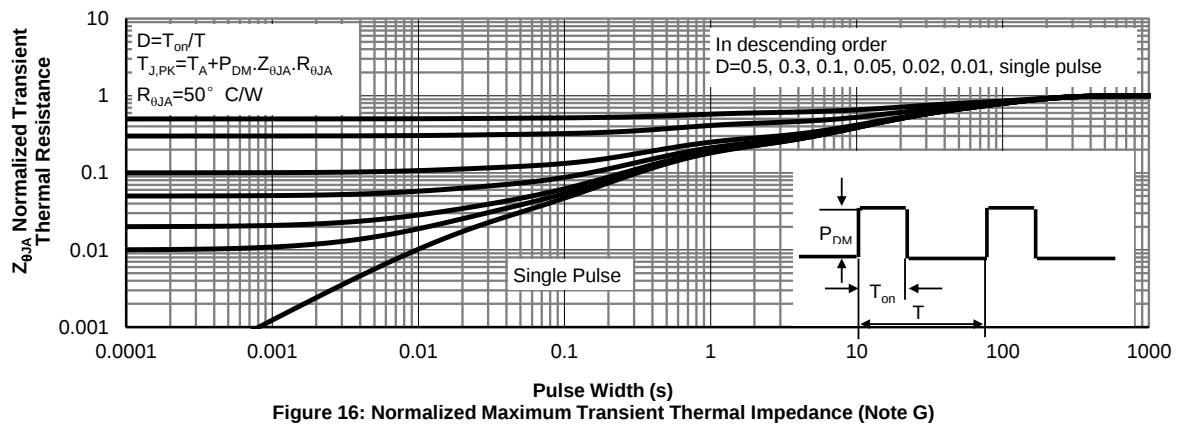
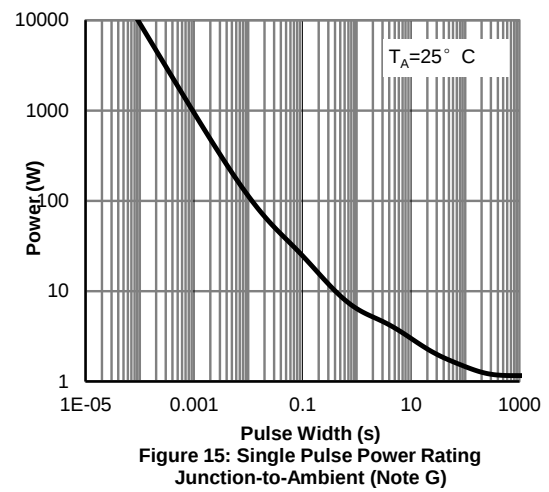
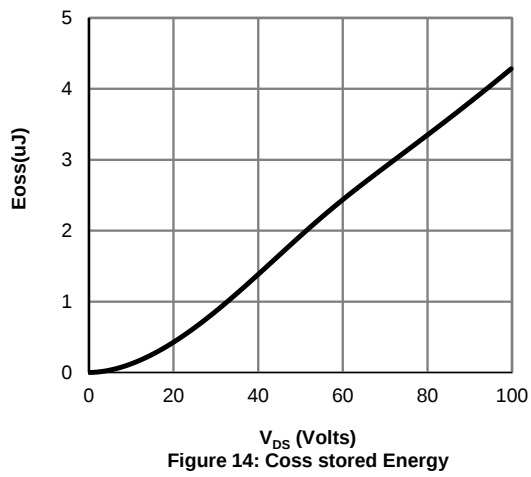
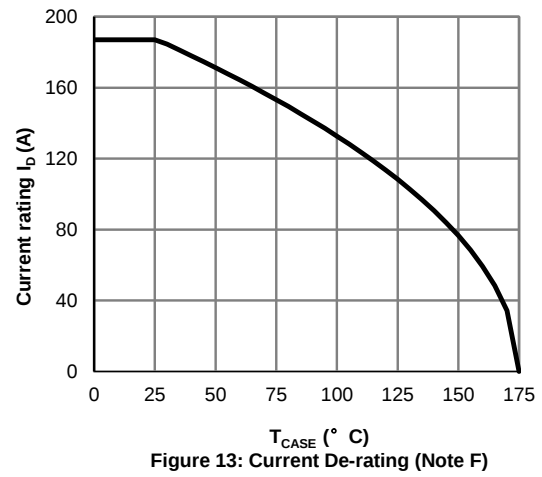
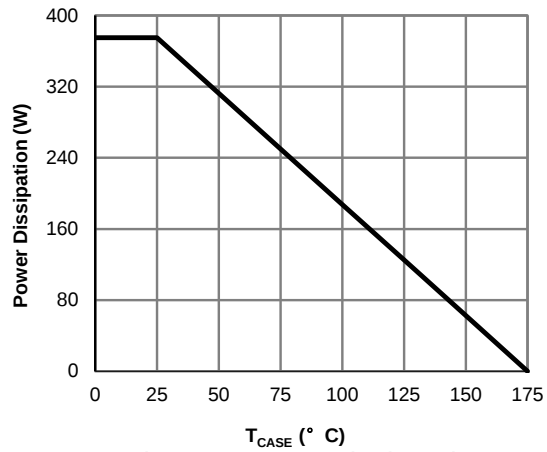


Figure 6: Body-Diode Characteristics (Note E)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



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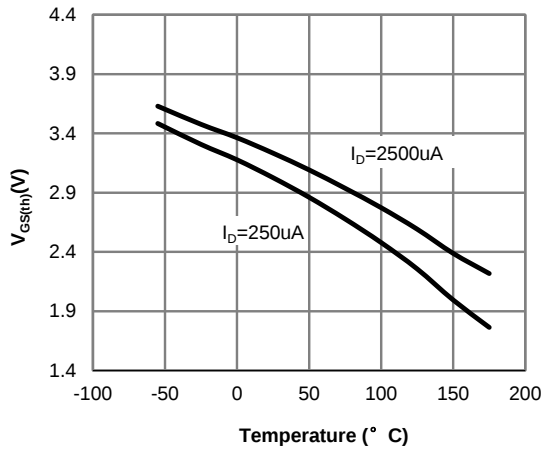


Figure 17:  $V_{GS(th)}$  vs Junction Temperature

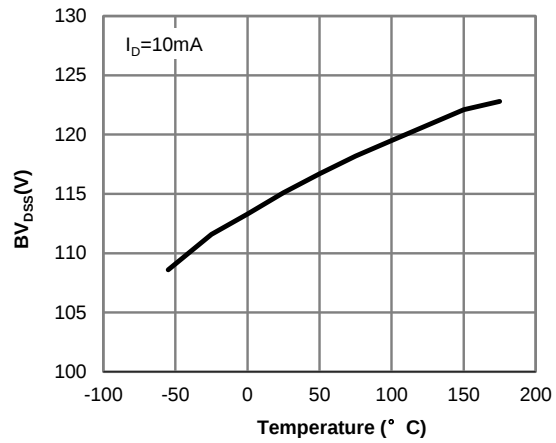


Figure 18: Drain-source breakdown voltage vs. Junction Temperature

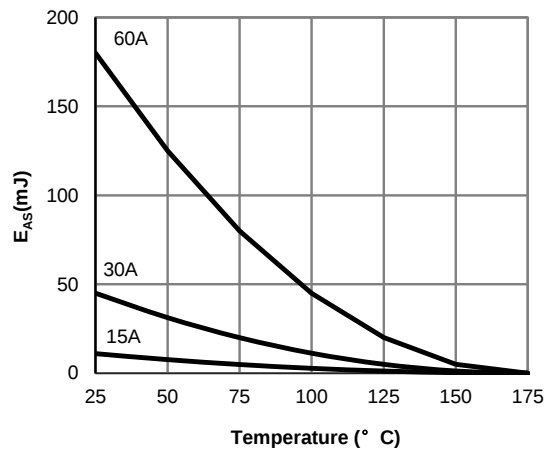


Figure 19:  $E_{AS}$  vs Junction Temperature

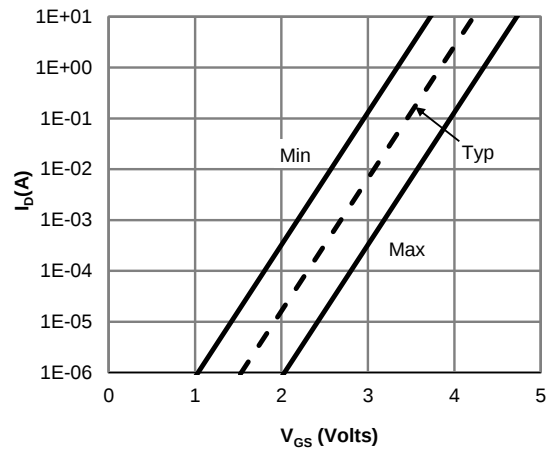


Figure 20: Transfer Characteristics (Note E)

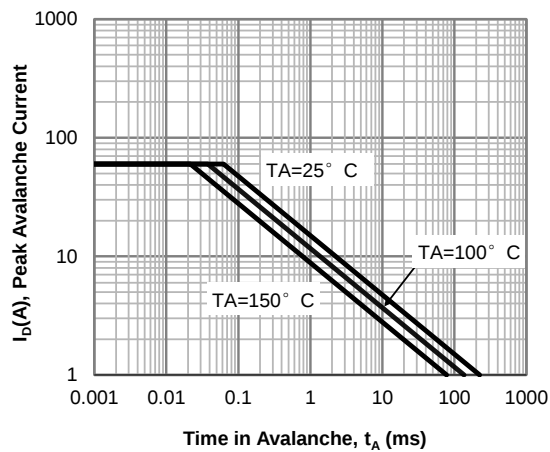


Figure 21: Single Pulse Avalanche capability

Figure A: Gate Charge Test Circuit & Waveforms

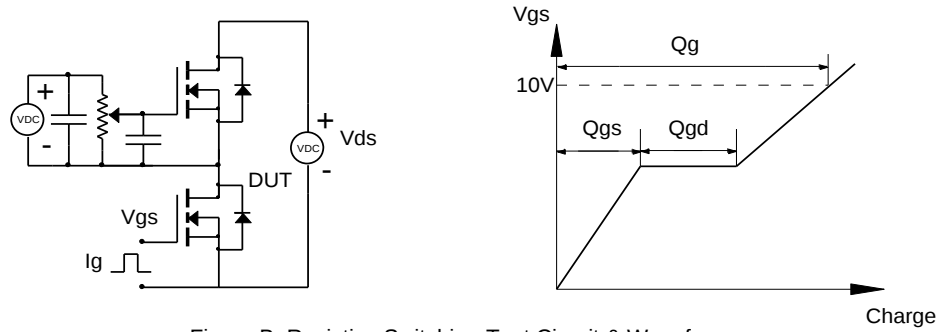


Figure B: Resistive Switching Test Circuit & Waveforms

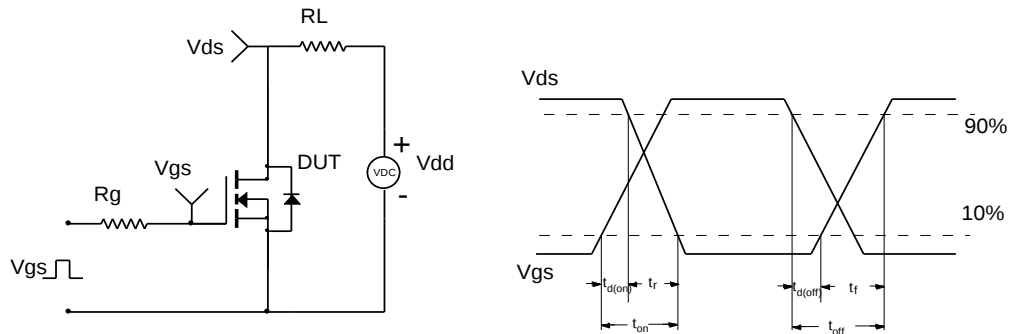


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

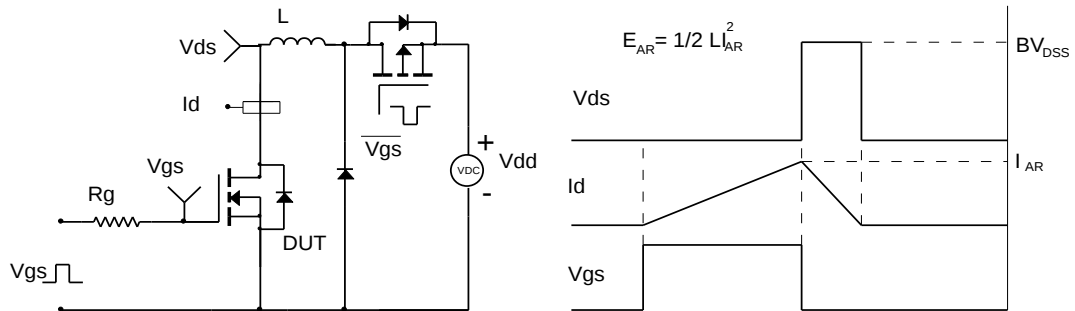


Figure D: Diode Recovery Test Circuit & Waveforms

